

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/779,785 | Applicant(s)/Patent Under Reexamination LEE, KUN-HAK | |
| | Examiner Redentor M. Pasia | Art Unit 2616 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-2006/0209864 A1 | 09-2006 | Kerkhof, Roger | 370/419 |
| * | B | US-6,782,097 B2 | 08-2004 | Witty et al. | 379/399.01 |
| * | C | US-7,092,362 B1 | 08-2006 | Demakakos et al. | 370/249 |
| * | D | US-7,023,875 B2 | 04-2006 | Czerwiec et al. | 370/463 |
| * | E | US-6,658,049 B1 | 12-2003 | McGhee et al. | 375/211 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.